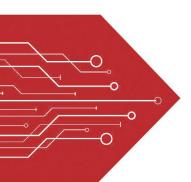
# MSKSEMI















**ESD** 

TVS

**TSS** 

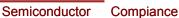
MOV

**GDT** 

**PLED** 

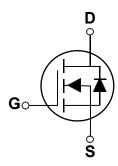
# Broduct data sheet







SOT-23



#### **Features**

- 20V, 4A,  $RDS(ON) = 30m\Omega@VGS = 4.5V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

### **Applications**

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
20V	$30 \text{m}\Omega$	4A

### **Absolute Maximum Ratings** Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
V <sub>G</sub> s	Gate-Source Voltage	±12	V
	Drain Current – Continuous (T <sub>C</sub> =25°C)	4	А
ID	Drain Current – Continuous (T <sub>C</sub> =100°C)	3.2	А
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	16	А
Б	Power Dissipation (Tc=25°C)	1.56	W
P <sub>D</sub>	Power Dissipation – Derate above 25°C	0.012	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W







# Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.02		V/°C
	Dunin Sauras Laskana Cumant	V <sub>DS</sub> =20V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
loss	Drain-Source Leakage Current	V <sub>DS</sub> =16V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			10	uA
Igss	Gate-Source Leakage Current	V <sub>GS</sub> =±12V , V <sub>DS</sub> =0V			±100	nA

#### **On Characteristics**

R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		30	45	mΩ
NDS(ON)	Static Dialii-Source Off-Nesistance	V <sub>GS</sub> =2.5V , I <sub>D</sub> =3A		45	70	11132
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA		0.6	1.2	V
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient			2		mV/°C
gfs	s Forward Transconductance V <sub>DS</sub> =10V , I <sub>S</sub> =2A			4.4		S

**Dynamic and switching Characteristics** 

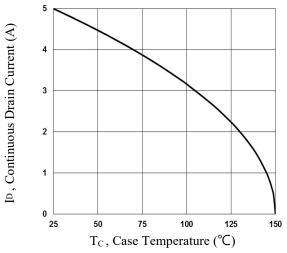
Qg	Total Gate Charge <sup>2,3</sup>			5.8	
$Q_{gs}$	Gate-Source Charge <sup>2, 3</sup>	V <sub>DS</sub> =10V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		0.6	 nC
$Q_{gd}$	Gate-Drain Charge <sup>2, 3</sup>			1.5	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2, 3</sup>			2.9	
Tr	Rise Time <sup>2, 3</sup>	$V_{DD}$ =10V , $V_{GS}$ =4.5V , $R_{G}$ =25 $\Omega$ $I_{D}$ =1A		8.4	 0
$T_{d(off)}$	Turn-Off Delay Time <sup>2, 3</sup>			19.2	 nS
Tf	Fall Time <sup>2,3</sup>			5.6	
Ciss	Input Capacitance			500	
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , F=1MHz		50	 pF
Crss	Reverse Transfer Capacitance			40	

Drain-So	Drain-Source Diode Characteristics and Maximum Ratings					
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	\\-\\-\\-\\-\\-\\-\\-\\-\\-\\-\\-\\\-\			4	Α
Isм	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			8	Α
VsD	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	V

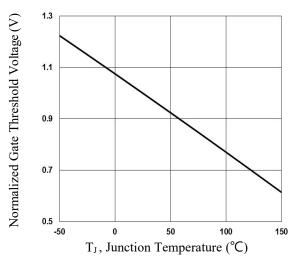
#### Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. Essentially independent of operating temperature.





Continuous Drain Current vs. Tc



Normalized Vth vs. TJ

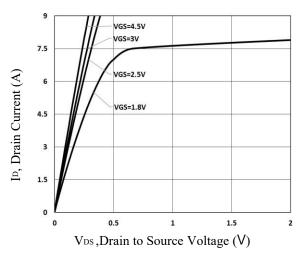
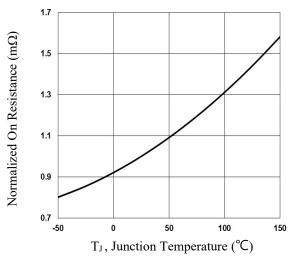
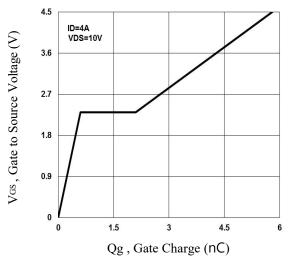


Fig.5 Typical Output Characteristics



Normalized RDSON vs. T<sub>J</sub> Fig.2



**Gate Charge Waveform** 

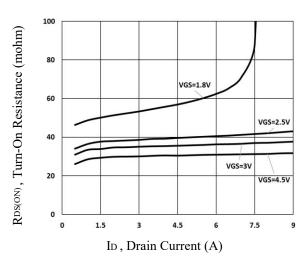


Fig.6 Turn-On Resistance vs. ID

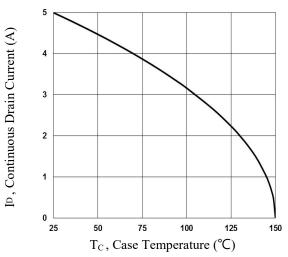


Fig.1 Continuous Drain Current vs. Tc

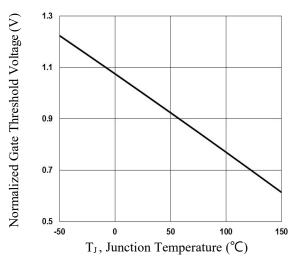


Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

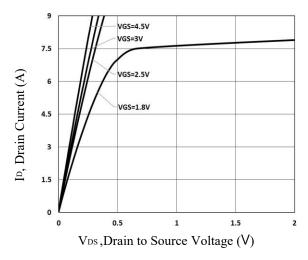


Fig.5 Typical Output Characteristics

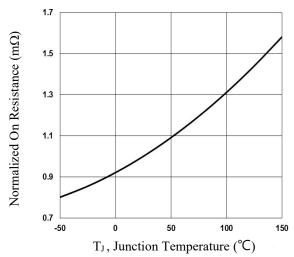
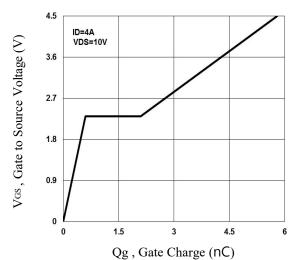


Fig.2 Normalized RDSON vs. T<sub>J</sub>



**Gate Charge Waveform** 

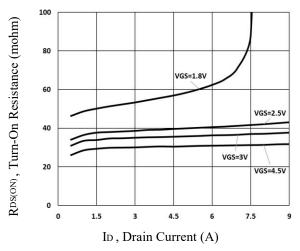


Fig.6 Turn-On Resistance vs. ID





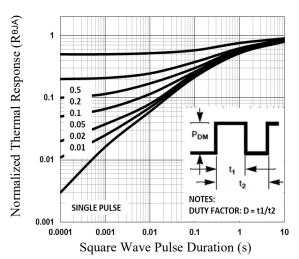


Fig.7 Normalized Transient Impedance

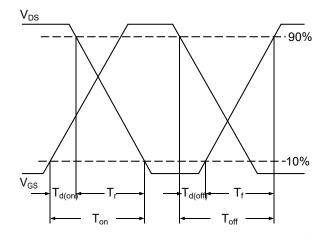


Fig.9 Switching Time Waveform

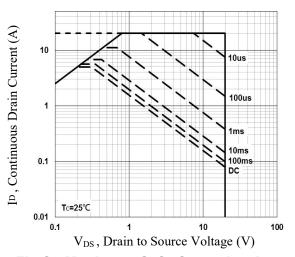


Fig.8 Maximum Safe Operation Area

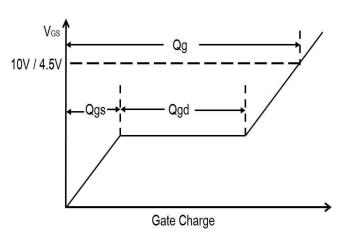


Fig.10 Gate Charge Waveform

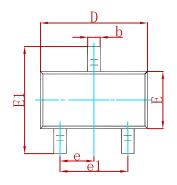


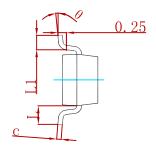


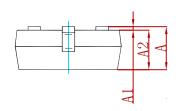




### **PACKAGE MECHANICAL DATA**

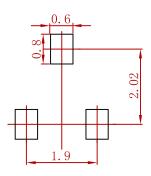






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
Е	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	) TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

# **Suggested Pad Layout**



- 1.Controlling dimension:in millimeters.2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

# **REEL SPECIFICATION**

P/N	PKG	QTY
IRLML2502	SOT-23	3000



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DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 IPS60R360PFD7SAKMA1
DMN2990UFB-7B SSM3K35CT,L3F IPLK60R1K0PFD7ATMA1 2N7002W-G MCAC30N06Y-TP IPWS65R035CFD7AXKSA1
MCQ7328-TP SSM3J143TU,LXHF DMN12M3UCA6-7 PJMF280N65E1\_T0\_00201 PJMF380N65E1\_T0\_00201
PJMF280N60E1\_T0\_00201 PJMF600N65E1\_T0\_00201 PJMF900N65E1\_T0\_00201